

# Search Notes



Application/Control No.

10/694,057

Examiner

Frederick J. Parker

Applicant(s)/Patent under Reexamination

ONOYAMA ET AL.

Art Unit

1762

## SEARCHED

Class	Subclass	Date	Examiner
427	470	↑	↑
	475	↑	↑
	485	8/3/06	JP
	385-5	↓	↓

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
427	470	↑	↑
	475	↑	↑
	485	8/3/06	JP
	385-5	↓	↓

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST with word modifiers 427/461, 470, 475, 483, 485, 385.5	8/3/06	JP
EAST & E Dan inventor name searched	8/3/06	JP